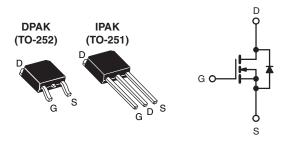


Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	60 Vac = 10 V 0.10			
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.10		
Q _g (Max.) (nC)	25			
Q _{gs} (nC)	5.8			
Q _{gd} (nC)	11			
Configuration	Single			



N-Channel MOSFET

FEATURES

- Halogen-free According to IEC 61249-2-21 **Definition**
- Dynamic dV/dt Rating
- Surface Mount (IRFR020, SiHFR020)
- Available in Tape and Reel
- · Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC



HALOGEN

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The DPAK is designed for surface mounting using vapor phase, infrared, or wave soldering techniques.

ORDERING INFORMATION					
Package	DPAK (TO-252)	DPAK (TO-252)	IPAK (TO-251)		
Lead (Pb)-free and Halogen-free	SiHFR020-GE3	SiHFR020TR-GE3	SiHFU020-GE3		
Lead (Pb)-free	IRFR020PbF	IRFR020TRPbFa	IRFU020PbF		
	SiHFR020-E3	SiHFR020T-E3ª	SiHFU020-E3		
SnPb	IRFR020	IRFR020TR ^a	IRFU020		
	SiHFR020	SiHFR020T ^a	SiHFU020		

Note

a. See device orientation.

ABSOLUTE MAXIMUM RATINGS T _C = 25 °C, unless otherwise noted						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	60	V	
Gate-Source Voltage			V_{GS}	± 20	7	
Continuous Drain Current	V _{GS} at 10 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	l _D	14		
	V _{GS} at 10 V	T _C = 100 °C		9.0	A	
Pulsed Drain Current ^a			I _{DM}	56		
Linear Derating Factor				0.33	W//9C	
Linear Derating Factor (PCB Mount)e				0.020	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	91	mJ	
Maximum Power Dissipation	T _C =	: 25 °C	В	42	W	
Maximum Power Dissipation (PCB Mount)e	T _A =	: 25 °C	P_D	2.5	VV	
Peak Diode Recovery dV/dtc			dV/dt	5.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for	10 s		260 ^d]	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD}=25$ V, starting $T_J=25$ °C, L=541 µH, $R_g=25$ Ω , $I_{AS}=14$ A (see fig. 12). c. $I_{SD}\leq 17$ A, $dI/dt\leq 110$ A/µs, $V_{DD}\leq V_{DS}$, $T_J\leq 150$ °C.

- When mounted on 1" square PCB (FR-4 or G-10 material).

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFR020, IRFU020, SiHFR020, SiHFU020

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THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	-	110		
Maximum Junction-to-Ambient (PCB Mount) ^a	R _{thJA}	-	-	50	°C/W	
Maximum Junction-to-Case (Drain)	R_{thJC}	-	-	3.0		

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static				•		•	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.073	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}, I_D = 250 \mu A$		-	4.0	V
Gate-Source Leakage	I _{GSS}	,	$V_{GS} = \pm 20 \text{ V}$		-	± 100	nA
Zana Oata Waltana Duain Ouwant		V _{DS} :	$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}$		-	25	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 48 V,	V _{GS} = 0 V, T _J = 125 °C	-	-	250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	$I_D = 8.4 A^b$	-	-	0.10	Ω
Forward Transconductance	9 _{fs}	V _{DS} :	= 25 V, I _D = 8.4 A	6.2	-	-	S
Dynamic							
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	640	-	
Output Capacitance	C _{oss}	$V_{DS} = 25 \text{ V},$ $V_{DS} = 25 \text{ V},$ f = 1.0 MHz, see fig. 5		-	360	-	pF
Reverse Transfer Capacitance	C _{rss}			-	79	-	
Total Gate Charge	Qg			-	-	25	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_D = 17 \text{ A}, V_{DS} = 48 \text{ V},$ see fig. 6 and 13^b	-	-	5.8	
Gate-Drain Charge	Q _{gd}	1	occ lig. o and ro	-	-	11	
Turn-On Delay Time	t _{d(on)}			-	13	-	
Rise Time	t _r	$V_{DD}=30$ V, $I_{D}=17$ A, $R_{G}=18$ Ω , $R_{D}=1.7$ Ω , see fig. 10^{b}		-	58	-	ns
Turn-Off Delay Time	t _{d(off)}			-	25	-	
Fall Time	t _f			-	42	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact ^c		-	4.5	-	ml l
Internal Source Inductance	L _S			-	7.5	-	nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET sym showing the	MOSFET symbol showing the		-	14	Α
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	56	
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 14 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	1.5	V
Body Diode Reverse Recovery Time	t _{rr}	T _ 05 °C !	_ 17 A dl/dt . 100 A/v-b	-	88	180	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$-$ T _J = 25 °C, I _F = 17 A, dl/dt = 100 A/ μ s ^b		-	0.29	0.64	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	on is dor	ninated b	y L _s and	L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %.

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

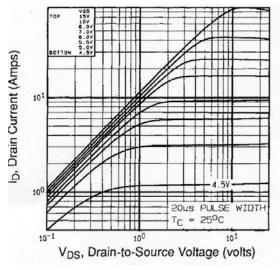


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

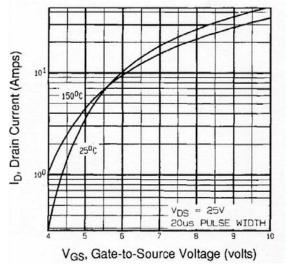


Fig. 3 - Typical Transfer Characteristics

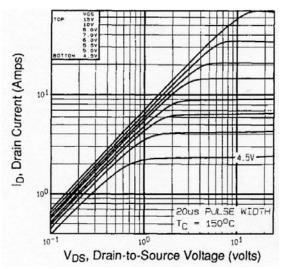


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

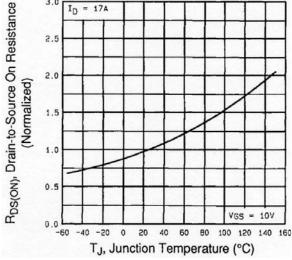


Fig. 4 - Normalized On-Resistance vs. Temperature

IRFR020, IRFU020, SiHFR020, SiHFU020

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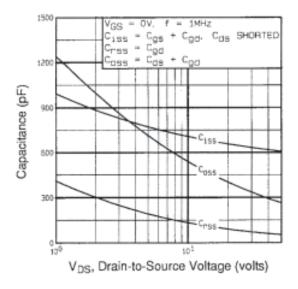


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

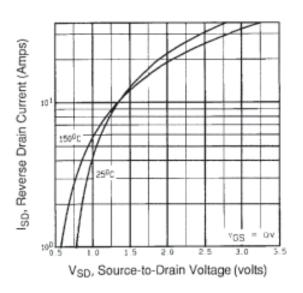


Fig. 7 - Typical Source-Drain Diode Forward Voltage

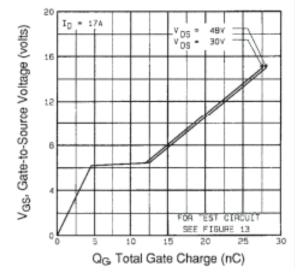


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

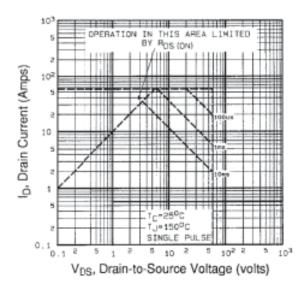


Fig. 8 - Maximum Safe Operating Area

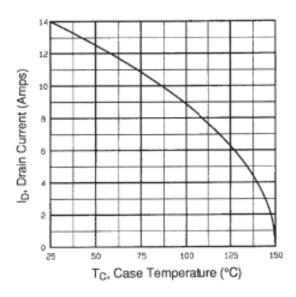


Fig. 9 - Maximum Drain Current vs. Case Temperature

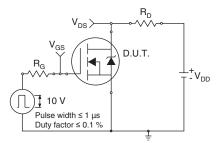


Fig. 10a - Switching Time Test Circuit

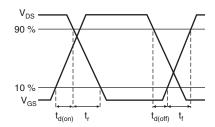


Fig. 10b - Switching Time Waveforms

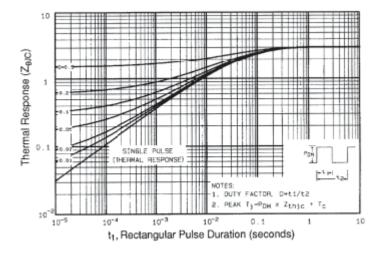


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



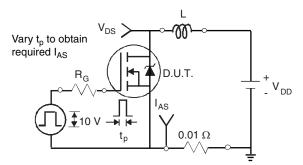


Fig. 12a - Unclamped Inductive Test Circuit

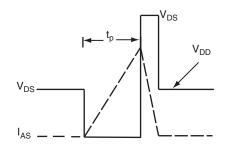


Fig. 12b - Unclamped Inductive Waveforms

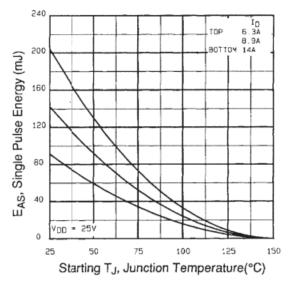


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

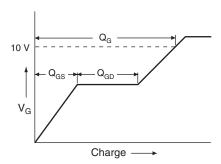


Fig. 13a - Basic Gate Charge Waveform

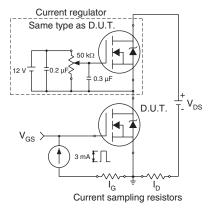
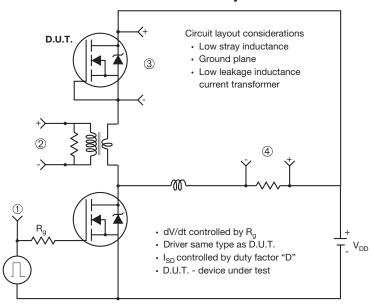


Fig. 13b - Gate Charge Test Circuit

Peak Diode Recovery dV/dt Test Circuit



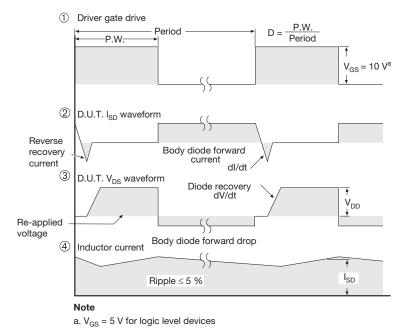


Fig. 14 - For N-Channel

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